

Search Notes

Application/Control No.

10/617,172

Examiner

Tianjie Chen

Applicant(s)/Patent under
Reexamination

KIM ET AL.

Art Unit

2652

SEARCHED

Class	Subclass	Date	Examiner
360	98.08		
	99.12		
	99.05		
720	604	5/25/2005	TJ

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East Report	5/25/2005	TJ